

10/549305

FORM 1449 (S&J Version) INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Docket No.: 29302.0049	10/549305
	Applicant: R. KUGE et al	
	Application No.: (new - based on PCT/IP2003/003152)	
	Filing Date: 2005 REC D PCT/IP10 16 SEP 2005	
	Examiner: Matthew Benvenuti IV Group Art Unit: 4159	

U.S. PATENT DOCUMENTS						
Examiner's Initials*	Document No.	Date MM/YYYY	Inventor	Class	Subclass	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS							
Examiner's Initials*	Document No.	Date MM/YYYY	Country	Class	Subclass	Translation	
						Yes	No
/M.B./	2000-302725	10/2000	Japan				x
	2001-139038	5/2001	Japan				x
	9-207948	8/1997	Japan				x
	11-321882 II/99	11/2999	Japan				x
	3-240651	10/1991	Japan				x

OTHER DOCUMENTS	
Examiner's Initials*	Include author, title of article, title of item (book, journal, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
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Examiner's Signature	/Matthew Benvenuti II/	Date Considered	09/23/2008
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

6/18/09
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Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 29302.0049	Application No. 10/549,305
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Raizo KUGE et al	
		Filing Date November 10, 2005	Group Art Unit 3677 4159

U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
/M.B./	AA	5,116,140	5/26/1992	Hirashima	383	206	
	AB						
	AC						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AD	WO 02/22452	9/2000 3/02	WIPO			Abstract	
	AE	2002-104440	4/2002	Japan			Abstract	
	AF	3-56248	3/1991	Japan			Abstract	
	AG	2 341 591	3/2000	UK				
	AH	1-308754	12/2989 12/89	Japan			Abstract	
	AI							
	AJ							
	AK							
	AL							
	AM							
	AN							
	AO							
	AP							
	AQ							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AR	
	AS	
V	AT	

Examiner Signature /Matthew Benvenuti II/	Date Considered 09/23/2008
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